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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/790,880	03/03/2004	Satoru Akiyama	500.43581X00	4729
20457	7590	04/07/2008	EXAMINER	
ANTONELLI, TERRY, STOUT & KRAUS, LLP			TRAN, DENISE	
1300 NORTH SEVENTEENTH STREET				
SUITE 1800			ART UNIT	PAPER NUMBER
ARLINGTON, VA 22209-3873			2188	
			MAIL DATE	DELIVERY MODE
			04/07/2008	PAPER

**Please find below and/or attached an Office communication concerning this application or proceeding.**

The time period for reply, if any, is set in the attached communication.

<b>Office Action Summary</b>	<b>Application No.</b>	<b>Applicant(s)</b>	
	10/790,880	AKIYAMA ET AL.	
	<b>Examiner</b>	<b>Art Unit</b>	
	Denise Tran	2188	

-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --

#### Period for Reply

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) OR THIRTY (30) DAYS, WHICHEVER IS LONGER, FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
- If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
- Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133). Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

#### Status

1) Responsive to communication(s) filed on 10 December 2007.  
 2a) This action is **FINAL**.                    2b) This action is non-final.  
 3) Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

#### Disposition of Claims

4) Claim(s) 1-3,6-12 and 20-28 is/are pending in the application.  
 4a) Of the above claim(s) \_\_\_\_\_ is/are withdrawn from consideration.  
 5) Claim(s) \_\_\_\_\_ is/are allowed.  
 6) Claim(s) 1-3,6-12 and 20-28 is/are rejected.  
 7) Claim(s) \_\_\_\_\_ is/are objected to.  
 8) Claim(s) \_\_\_\_\_ are subject to restriction and/or election requirement.

#### Application Papers

9) The specification is objected to by the Examiner.  
 10) The drawing(s) filed on 03 March 2004 is/are: a) accepted or b) objected to by the Examiner.  
 Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).  
 Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).  
 11) The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.

#### Priority under 35 U.S.C. § 119

12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).  
 a) All    b) Some \* c) None of:  
 1. Certified copies of the priority documents have been received.  
 2. Certified copies of the priority documents have been received in Application No. \_\_\_\_\_.  
 3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).

\* See the attached detailed Office action for a list of the certified copies not received.

#### Attachment(s)

1) <input type="checkbox"/> Notice of References Cited (PTO-892)	4) <input type="checkbox"/> Interview Summary (PTO-413)
2) <input type="checkbox"/> Notice of Draftsperson's Patent Drawing Review (PTO-948)	Paper No(s)/Mail Date. _____ .
3) <input type="checkbox"/> Information Disclosure Statement(s) (PTO/SB/08)	5) <input type="checkbox"/> Notice of Informal Patent Application
Paper No(s)/Mail Date _____.	6) <input type="checkbox"/> Other: _____ .

## DETAILED ACTION

1. The applicant's amendment filed 12/10/07. Claims 1-3, 6-12, and claims 20-28 are presented for examination. Claims 4-5 and 13-19 have been canceled.

2. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negated by the manner in which the invention was made.

5. Claims 1-3, 6-12 and 20-28 are rejected under 35 U.S.C. 103(a) as being unpatentable over Akiyama et al., US 2003/0033492, (hereinafter Akiyama), in view of Atwood et al., "SESO Memory: a CMOS Compatible High Density Embedded Memory technology for Mobile Applications, " 2002, Symposium on VLSI Circuit Digest of Technical Papers pp. 154-155, (2000) (hereinafter Atwood).

Claim 1, Akiyama teaches a semiconductor device comprising:

a plurality of memory banks, each having a plurality of memory cells (e.g., figs. 1, 7, el. bank0-bank4; [0003]); and

a cache memory for mediating an access to the memory from the outside (e.g., figs 1, 6-7, cachemen; [0030]; [0039]), said cache memory having a number of way equal to or larger than a value (i.e., 1 or 2 ways; e.g., figs 1, 6-7, cachemen; [0074]; [0086]) determined inherently by a ratio (m/n) of a write cycle (m) of said memory cells

to a read cycle (n) of said memory cells (e.g., fig. 8, , a read cycle n =1 or 2 and write cycle m = 1; m/n = 1/1 = 1 or m/n= 1/2); and

wherein, when first data is written into said semiconductor device from the outside, said cache memory does not hold an address at which said first data is to be written (e.g., [0056]), data held in an associated entry of said cache memory is written back to one of said plurality of memory banks (e.g., [0056]), and said first data is written into said cache memory (e.g., [0056]), and

wherein, when data is written back to one of said plurality of memory banks, wherein a first memory bank included in said plurality of memory banks cannot accept an access from the outside, the data is written back to a second memory bank included in said plurality of memory banks (e.g., [0058]).

Akiyama does not explicitly show memory cells which are slower in a write operation than in a read operation. Atwood teaches memory cells which are slower in a write operation than in a read operation (e.g., page 154, column 2, paragraph 2). It would have been obvious to one of ordinary skill in the art at the time the invention was made to apply the teaching of Atwood into the system of Akiyama because it would provide a high density, low power embedded memory.

Claim 20, Akiyama teaches a semiconductor device comprising:  
a plurality of memory banks, each having a plurality of memory cells (e.g., figs. 1, 7, el. bank0-bank4; [0003]); and

a cache memory for mediating an access to the memory from the outside (e.g., figs 1, 6-7, cachemen; [0030]; [0039]), said cache memory having a number of way equal to or larger than a value (i.e., 1 or 2 ways; e.g., figs 1, 6-7, cachemen; [0074]; [0086]) determined inherently by a ratio (m/n) of a write cycle (m) of said memory cells to a read cycle (n) of said memory cells (e.g., fig. 8, , a read cycle n =1 or 2 and write cycle m = 1; m/n = 1/1 = 1 or m/n= 1/2); and

an internal data bus for coupling said cache memory to said memory banks (e.g., page 11, claim 5); and

a plurality of data input/output nodes for inputting/outputting data from/to the outside (e.g., page 11, claim 5),

wherein said cache memory has a cache line comprised of a plurality of sublines (e.g., page 11, claims 1 and 5), and

A=N.B is satisfied, where N is the number of said plurality of sublines, A is a bus width of said internal data bus, and B is a bus width of said external data bus (e.g., page 11, claim 5),

Wherein, when data is written back to one of said plurality of memory banks, wherein a first memory bank included in said plurality of memory banks cannot accept an access from the outside, the data is written back to a second memory bank included in said plurality of memory banks (e.g., [0058]).

Akiyama does not explicitly show memory cells which are slower in a write operation than in a read operation. Atwood teaches memory cells which are slower in a write operation than in a read operation (e.g., page 154, column 2, paragraph 2). It

would have been obvious to one of ordinary skill in the art at the time the invention was made to apply the teaching of Atwood into the system of Akiyama because it would provide a high density, low power embedded memory.

Claims 2-3, and 21-22, Akiyama teaches said cache memory has a plurality of sets corresponding to the number of ways, and each of said plurality of sets has a capacity for storing whole data stored in one of said plurality of memory banks (e.g., [0090]); when said cache memory holds data corresponding to an access to said semiconductor device from the outside, the data is communicated from said cache memory (e.g.,[0030]).

Claims 6-7 and 23, Akiyama teaches a plurality of data input/output nodes for inputting/outputting data to/from the outside, wherein each said data input/output node has a data width equal to a data width of an external data bus for inputting/outputting information to/from said semiconductor device; an internal data bus for coupling said cache memory to said memory banks (e.g., page 11, claim 5; page 3, [0027]); wherein said cache memory has a cache line comprised of a plurality of sublines, and A=N. B is satisfied, where N is the number of said plurality of sublines, A is a bus width of said internal data bus, and B is a bus width of said external data bus (e.g., page 11, claim 5); said cache memory has a plurality of flags each associated with one subline for managing data held thereon (e.g., fig. 3A, v0-v3, D0-D3);

Claims 8-9, 12, 24-25, and 28, Akiyama teaches when said flag indicates data on said subline as invalid, a write-back operation is not performed from said cache memory

to said memory bank (e.g., fig. 2B, S205; [0057]-[0058]); when a flag indicates that data on said subline has been updated, a data write operation is not performed from said memory bank to said cache memory (e.g., [0058]); and wherein said cache memory comprises SRAM memory cells [e.g., 0027].

Claims 10-11 and 26-27, Akiyama teaches wherein said cache memory comprises SRAM memory cells [0027]. Akiyama does not explicitly show wherein each said memory cell is either a SESO (Single Electron Shut Off) memory cell or a phase change memory cell. Atwood teaches memory cell is either a SESO (Single Electron Shut Off) memory cell or a phase change memory cell (e.g., page 154, column 2, paragraph 2). It would have been obvious to one of ordinary skill in the art at the time the invention was made to apply the teaching of Atwood into the system of Akiyama because it would provide a high density, low power embedded memory.

10. Applicant's arguments filed 12/10/07 have been fully considered but they are not persuasive.

11. In the remarks, the applicant argued that neither Akiyama nor Atwood teaches when data is written back to one of said plurality of memory banks, wherein a first memory bank included in said plurality of memory banks cannot accept an access from the outside, the data is written back to a second memory bank included in said plurality of memory banks.

The examiner disagreed with the applicant argument. According to Akiyama teaches, for example [0058], the requested “(bank address) is ‘8’ “ cannot accept an access from the outside, the data is “written back to the bank 4. Also, Akiyama, [0059], teaches writing back to the bank 4 when the other banks are refreshed.

12. Applicant's amendment necessitated the new ground(s) of rejection presented in this Office action. Accordingly, **THIS ACTION IS MADE FINAL**. See MPEP § 706.07(a). Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the date of this final action.

13. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Denise Tran whose telephone number is (571) 272-4189. The examiner can normally be reached on Monday and Thursday from 8:45 a.m. to 5:15 p.m.. The examiner can also be reached on alternate Friday

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Sough Hyung, can be reached on 571-272-4098. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see <http://pair-direct.uspto.gov>. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

/Denise Tran/

Primary Examiner, Art Unit 2188